IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent

cation of: Kevin Goodman

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Serial No.

10/062,619

Examiner:

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January 31, 2002

For:

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OF PROCESS COMPONENTS

INFORMATION DISCLOSURE STATEM

Commissioner for Patents Washington, DC 20231

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Sir:

The citation of information on the attached Form PTO-1449, "List of Art Cited by Applicant" is made pursuant to 37 C.F.R. §§ 1.56, 1.97, and 1.98. A copy of each cited item is enclosed.

The citation of this information does not constitute an admission of priority or that any cited item is available as a reference, or a waiver of any right the applicant may have under applicable statutes, Rules of Practice in patent cases, or otherwise.

Respectfully submitted,

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Our Docket: 17403-0003

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, Washington, DC 20231, on April 26, 2002.

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APPLICANT(S) Kevin Goodman MAN 0 2 2002				GROUP 2185		
U.S. PATENT DOCUMENTS						
EXAMINER'S DOCUME INITIALS NUMBE	DATE	NAME		CLASS	SUBCLASS	FILING DATE If Appropriate
6,304,9	51 10/16/01	Mealey et al.		711	206	10/01/98
6,205,58	30 03/20/01	Takahiro Hirose		717	11	09/09/98
6,105,1	08/15/00	Michael S. Ripley		711	165	06/30/97
6,065,10	05/16/00	Seng-Khoon Tng		711	209	07/23/97
6,061,7	73 05/09/00	Harvey et al.		711	206	05/03/96
5,960,46	66 09/28/99	28/99 Richard A. Belgard		711	213	08/04/97
5,943,00	08/24/99	Thomas et al.		345	515	05/01/97
5,940,80	08/17/99	Dave Wagner		711	202	07/18/97
5,875,48	37 02/23/99	Schwartz et al.		711	REØEIVE	ED 06/07/95
					MAY 0 7 2002	
				Technology Center 2100		
FOREIGN PATENT DOCUMENTS DOCUMENT DATE CONNERV NAME TRANSLATION						
NUMBE		COUNTRY NAME			Yes	NSLATION No
OTUED DEFEDENCES (Including Author Title Date Destinant Date Date Date Date Date Date Date Dat						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER DATE CONSIDERED						
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MLPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.						